




<p style="text-align: center;">Searched</p> 	<p>Application/Control No.</p> <p>10752675</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>LEE ET AL.</p>
	<p>Examiner</p> <p>Mehrpour, Naghmeh</p>	<p>Art Unit</p> <p>2617</p>

Class	SubClass	Date	Examiner
455	432.1	9/21/05	NM
	410		
	435.1		
	436		
713	156		
	158		
	175		
370	331		
	338		
713	150		
Updated		7/11/06	
Updated		9/15/06	
U.S. Patent and Trademark Office		Part of Paper No.:	9/15/06

Search Notes 	Application/Control No. 10752675	Applicant(s)/Patent Under Reexamination LEE ET AL.
	Examiner Mehrpour, Naghmeh	Art Unit 2617

Notes	Date	Examiner
East	9/21/05	NM
	7/11/06	NM
	9/15/06	NM
Temica Beamer	7/13/06	NM
Trinh Sonny	7/12/06	NM
Nguyen Vo	7/12/06	NM
Inventor searched done in eDAN	9/15/06	NM
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Interference Searched 	Application/Control No. 10752675	Applicant(s)/Patent Under Reexamination LEE ET AL.
	Examiner Mehrpour, Naghmeh	Art Unit 2617

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455	432.1	9/15/06	NM
	410		
Please see the attachment for interference search		9/15/06	NM
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